US00D545705S

(12) **United States Design Patent** (10) **Patent No.: US D545,705 S**
Voege (45) **Date of Patent: ** Jul. 3, 2007**

(54) **ANALYTE TEST METER**

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(73) Assignee: **Lifescan, Inc.**, Milpitas, CA (US)

(**) Term: **14 Years**

(21) Appl. No.: **29/245,055**

(22) Filed: **Dec. 16, 2005**

(51) **LOC (8) Cl.** **10-04**
(52) **U.S. Cl.** **D10/81**; D10/78
(58) **Field of Classification Search** D10/78, D10/81; D24/224, 232; 205/785.5, 787.5, 205/782; 204/415, 416, 403.02, 403.06, 204/409, 412, 435; 700/17, 431, 499, 866.3; 600/345; 345/824, 156, 158; 455/12.1, 455/86, 406; 422/50, 58, 61–63, 67, 68.1, 422/80, 82.03
See application file for complete search history.

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Primary Examiner—Antoine D. Davis
(74) *Attorney, Agent, or Firm*—Bernard E. Shay

(57) **CLAIM**

We claim the ornamental design for an analyte test meter, as shown and described.

DESCRIPTION

FIG. **1** is a top perspective view of the analyte test meter, as seen from the top, front and side;

FIG. **2** is a top perspective view of the analyte test meter, as seen from the top, back and side;

FIG. **3** is a top plan view thereof;

FIG. **4** is a bottom plan view thereof;

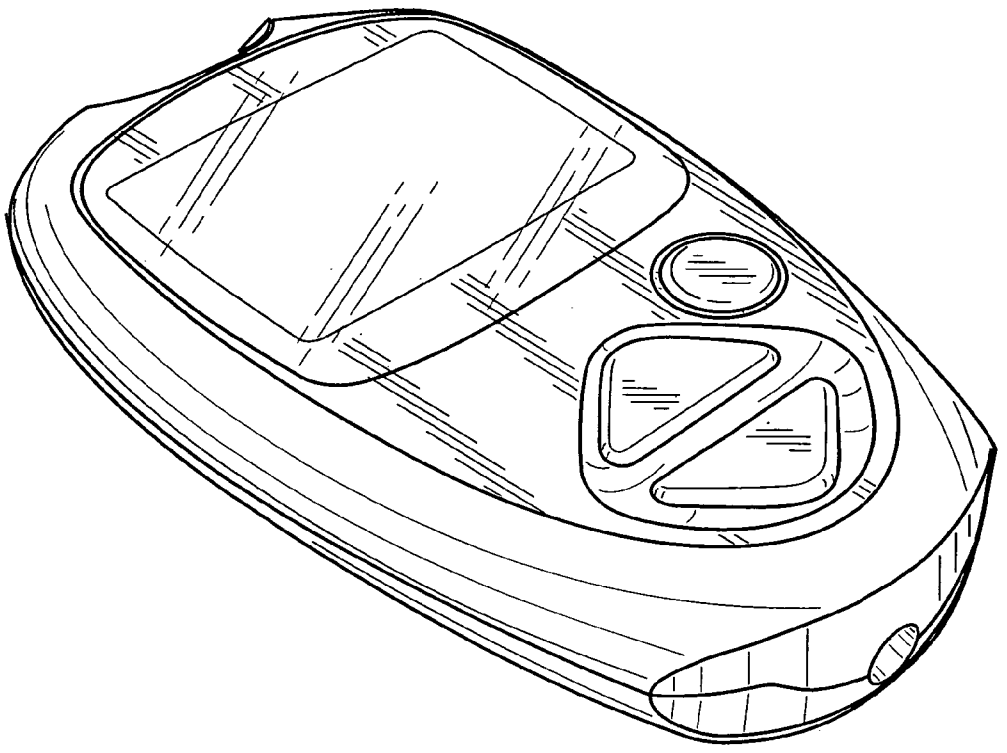
FIG. **5** is a first side elevational view thereof;

FIG. **6** is a second side elevational view thereof;

FIG. **7** is a front elevational view thereof; and,

FIG. **8** is a rear elevational view thereof.

1 Claim, 3 Drawing Sheets



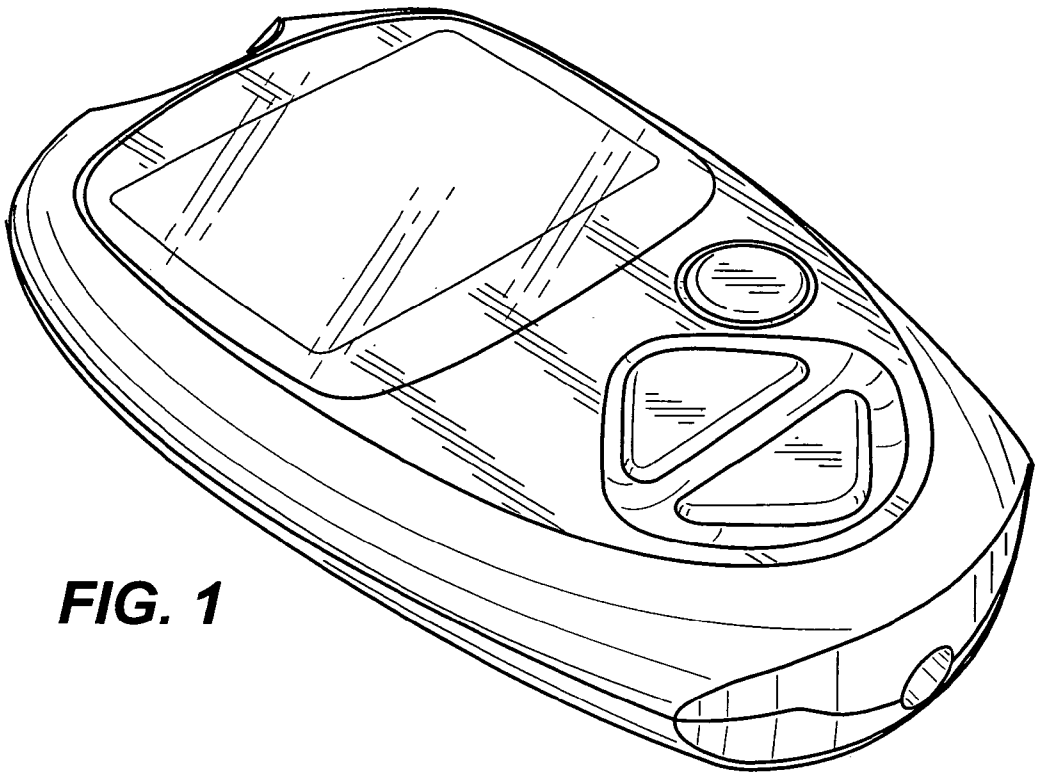


FIG. 1

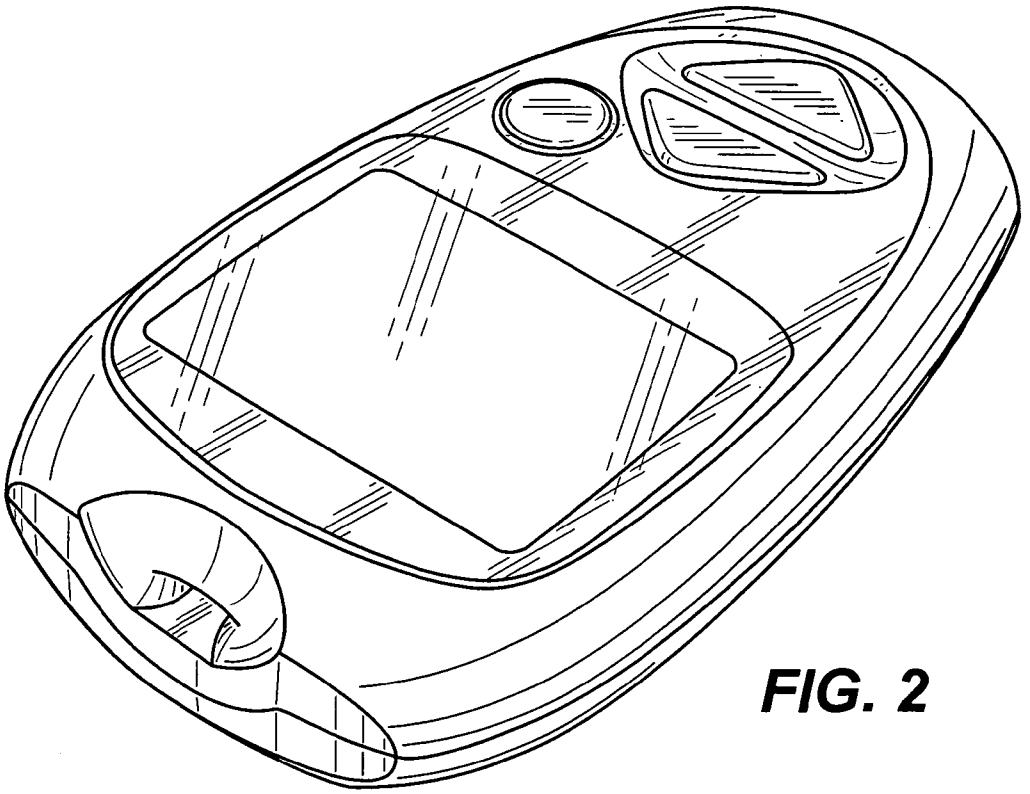


FIG. 2

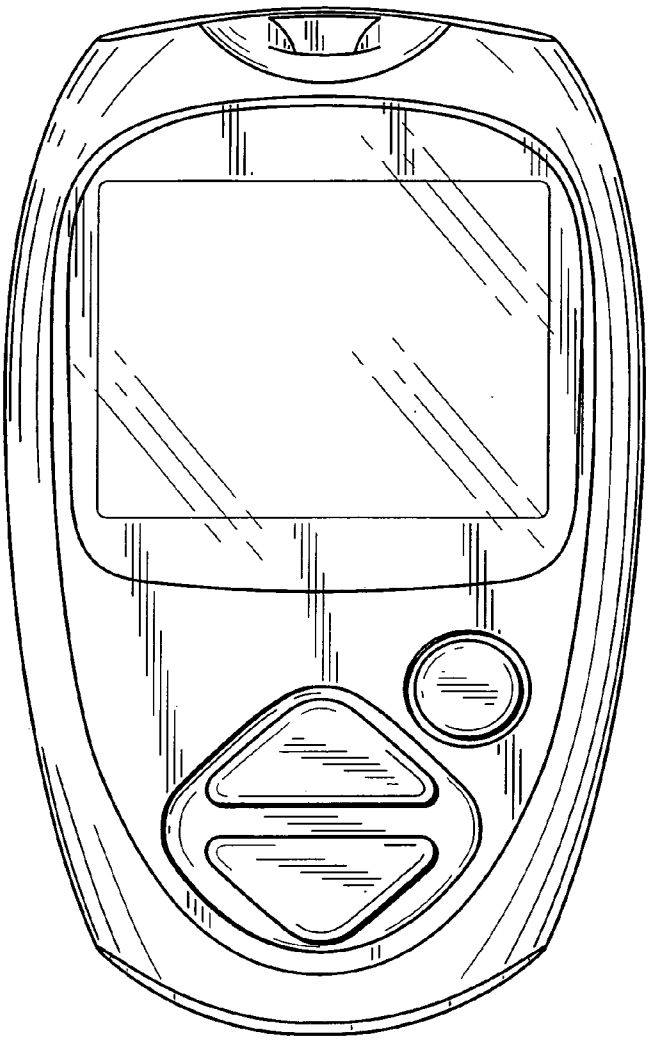


FIG. 3

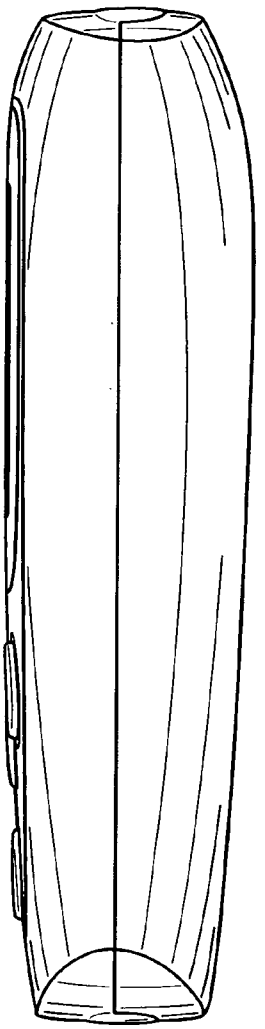


FIG. 5

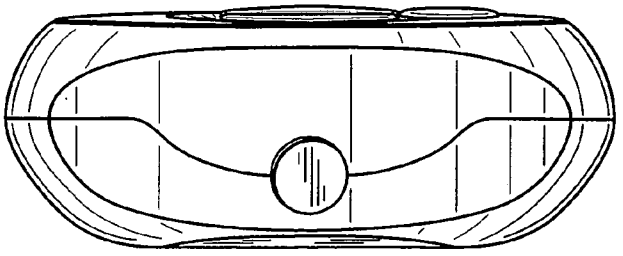


FIG. 7

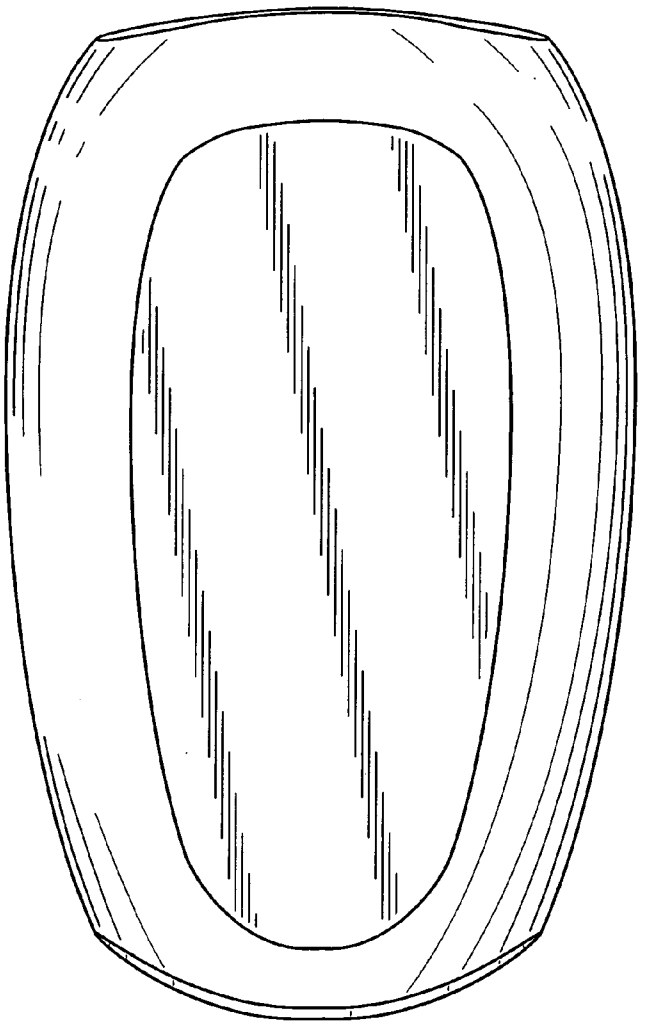


FIG. 4

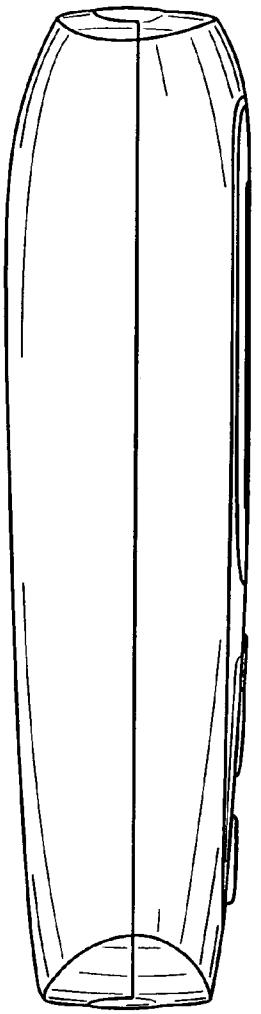


FIG. 6

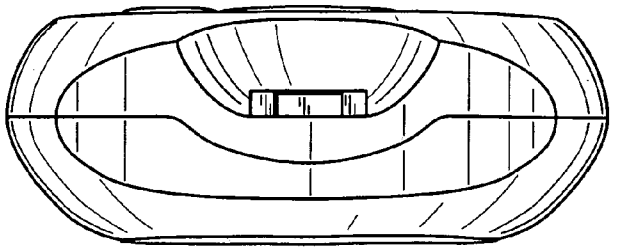


FIG. 8